<u>REPORT NO. : E930737</u>

EMC TEST REPORT				
According to				
<ol> <li>1) EN 55022: 1998+A1: 2000</li> <li>2) EN 61000-3-2:2000</li> <li>3) EN 61000-3-3: 1995+A1: 2001</li> <li>4) EN 50130-4:1995+A1:1998         <ul> <li>EN 61000-4-2: 1995+A2: 2001 / EN 61000-4-3: 1996+A2: 2001</li> <li>EN 61000-4-4: 1995+A2: 2001 / EN61000-4-5: 1995+A1: 2001</li> <li>EN 61000-4-6: 1996+A1: 2001 / EN 61000-4-11: 1994+A1: 2001</li> <li>Main Supply Voltage Variations</li> </ul> </li> </ol>				
EQUIPMENT : Door Entry Alarm & Counting System				
MODEL NO. : DES-700 & DC-500				
APPLICANT : Yuan Hsun Electric Co., Ltd.				
ADDRESS No. 57, Chung He Rd., Zuo-Ying Dist., Kaohsiung City 813, Taiwan, R. O. C.				
Test Engineer : <u>STEVEN CHEN</u>				
Checked by : <u>HADES HUANG</u>				
Issued Date : NOV. 23, 2004				
<ul> <li>The test report shall not be reproduced except in full, without the written approval of the laboratory.</li> <li>The report can't be used by the client to claim product endorsement by PEP Testing Laboratory.</li> <li>This report is only for the equipment which described in page 8.</li> </ul>				

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1. General				
1.1 General Information :				
Applicant :	Yuan Hsun Electric Co., Ltd.			
Address :	No. 57, Chung He Rd., Zuo-Ying Dist., Kaohsiung City 813, Taiwan, R. O. C.			
Manufacturer :	Yuan Hsun Electric Co., Ltd.			
Address :	No. 57, Chung He Rd., Zuo-Ying Dist., Kaohsiung City 813, Taiwan, R. O. C.			
Measurement P	rocedure : EN 55022 & EN 50130-4			

#### **1.2 Place of Measurement**

#### PEP TESTING LABORATORY

12-3Fl, No. 27-1, Lane 169, Kang-Ning St., Hsi-Chih, Taipei Hsien, Taiwan, R. O. C. TEL: 8862-26922097 FAX: 8862-26956236

> NVLAP LAB CODE 200097-0 FCC Registration No. : 90868 Nemko Aut. No. : ELA133 BSMI Aut. No. : SL2-IN-E-11,SL2-A1-E-11 VCCI Registration No. : C-493/R-477

### 1.3 Test standard

Tested for compliance with :

EN 55022:1998 +A1: 2000	- Information Technology Equipment – Radio disturbance characteristics - Limits and methods of measurement
EN 61000-3-2: 2000	- Electromagnetic compatibility (EMC) Part 3-2: Limits – Limits for harmonic current emissions (equipment input Current up to and including 16A per phase
EN 61000-3-3: 1995 +A1: 2001	- Electromagnetic compatibility (EMC) Part 3-2: Limits – Limitation of voltage fluctuations and flicker in low-voltage supply systems for equipment with rated current up to 16A

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	<ul> <li>Alarm systems – Part 4. Electromagnetic compatibility Product family standard: Immunity requirements for components of fire, intruder and social alarm systems</li> </ul>
EN 61000-4-2: 1995 +A2: 2001	- Electromagnetic compatibility (EMC) Part 4: Testing and measurement techniques, Section 2: Electrostatic discharge immunity test Basic EMC Publication
EN 61000-4-3: 1996 +A2: 2001	- Electromagnetic compatibility (EMC) Part 4: Testing and measurement techniques, Section 3: Radiated, radio- Frequency, electromagnetic field immunity test
EN 61000-4-4: 1995 +A2: 2001	<ul> <li>Electromagnetic compatibility (EMC) Part 4: Testing and measurement techniques, Section 4: Electrical fast transien / Burst immunity test Basic EMC publication</li> </ul>
EN 61000-4-5: 1995 +A1: 2001	- Electromagnetic compatibility (EMC) Part 4: Testing and measurement techniques, Section 5: Surge immunity test (includes corrigendum: 1995)
EN 61000-4-6: 1996 +A1: 2001	- Electromagnetic compatibility (EMC) Part 4: Testing and measurement techniques, Section 6: Immunity to conducte disturbances, induced by radio-frequency fields
EN 61000-4-11: 1994 +A1: 2001	- Electromagnetic compatibility (EMC) Part 4: Testing and measurement techniques, Section 11: Voltage dips, short interruptions and voltage variations immunity tests

2. Product Information/ Product Technical Judgement				
a.	EUT Name:	Door Entry Alarm & Counting System		
b.	Model No. :	DES-700 & DC-500		
c.	СРИ Туре :	N/A		
d.	<b>CPU Frequency</b> :	N/A		
e.	Crystal/Oscillator(s) :	4 MHz		
f.	Chassis Used :	ABS		
g.	Port/Connector(s) :	Input Jack $\times$ 1, Output Jack $\times$ 1, Power Jack $\times$ 1		
h.	Power Rating :	<ul> <li>Adapter</li> <li>1) Model No. : SP35-90300 Input : AC 230V 50Hz 50mA Output : DC 9V 300mA</li> <li>2) Model No. : 090-0250 Input : AC 120V 60Hz 5W Output : DC 9V 250mA</li> <li>3) Model No. : AD-0900300DS Input : AC 240V 50Hz Output : DC 9V 300mA</li> </ul>		
i.	Condition of the EUT :	<ul> <li>Prototype Sample</li> <li>Production Sample</li> </ul>		
j.	Test Item Receipt Date :	NOV. 16, 2004		

## **3. EUT Description and Test Conclusion**

The equipment under test (EUT) is Door Entry Alarm & Counting System model DES-700 & DC-500. The EUT that comes with operations of CHIME mode and ALARM mode is infrared sensor equipment used for the application of counting objects passing by. AC-DC adaptor supplies EUT DC 9V from AC mains. For more detail specification about the EUT, please refer to the user's manual.

Test method: According to the major function designed, the EUT configuration was set up for test. The test was carried out on EUT operational conditions of CHIME mode and ALARM mode. Besides original AC-DC adaptor model SP35-90300, two additional models: 090-0250 and AD-0900300DS were respectively used during conducted emission test. The worst-case test result of each test mode was recorded and provided in this report.

Conducted emission test:

The system was setup with the EMI diagnostic software running. The power line conducted EMI tests were run on the line and neutral conductors of the power cord and the results were recorded. The effect of varying the position of the interface cables has been investigated to find the worst-case configuration that produces maximum emission.

At the frequencies where the peak values of the emission exceeded the quasi-peak limit, the emissions were also measured with the quasi-peak detectors. The average detector also measured the emission either (A) quasi-peak values were under quasi-peak limit but exceeded average limit, or (B) peak values were under quasi-peak limit but exceeded average limit.

Radiated emission test:

The maximum readings were found by varying the height of antenna and then rotating the turntable. Both polarization of antenna, horizontal and vertical, are measured. The effect of varying the position of the interface cables has been investigated to find the configuration that produces maximum emission.

The highest emissions were also analyzed in details by operating the spectrum analyzer in fixed tuned quasi-peak mode to determine the precise amplitude of the emissions.

In addition, the following test standards are applicable for related tests being carried out on the same EUT configuration and operational condition kept during radiated emission test and conducted emission test:

EN 61000-3-2, EN 61000-3-3, EN 61000-4-2, EN 61000-4-3, EN 61000-4-4, EN 61000-4-5, EN 61000-4-6, and EN 61000-4-11.

12-3Fl, No. 27-1, Lane 169, Kang-Ning St., Hsi-Chih, Taipei Hsien, Taiwan, R. O. C. TEL: 886-2-26922097 FAX: 886-2-26956236

REPORT NO. : E930737 4. Modification(s): N/A 5. Test Software Used N/A

12-3Fl, No. 27-1, Lane 169, Kang-Ning St., Hsi-Chih, Taipei Hsien, Taiwan, R. O. C. TEL: 886-2-26922097 FAX: 886-2-26956236

REPORT NO. : E930737

## 6. Support Equipment Used

N/A

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#### REPORT NO. : E930737

## 7. EN 55022 Conducted Disturbance Test

Test Standard	Model No.	Result
EN 55022	DES-700 & DC-500	Passed

#### 7.1 Conducted Disturbance Test Limits at Main Ports

Frequency Rang	Limits dB(uV)			
	Class A ITE		Cla	ISS B ITE
MHz	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.50	79	66	66-56	56-46
0.50 - 5.0	73	60	56	46
5.0 - 30	73	60	60	50

Remarks: - If the average limit is met when a quasi-peak detector is used, the EUT shall be deemed to meet both limits and measurement with the average detector is unnecessary.

-The lower limit shall apply at the transition frequency

-The limit decreases linearly with the logarithm of the frequency in the range

0.15 MHz to 0.50 MHz.



Test Data: # 672 # 674 <line> # 674 <neutral> X Note 1. Level = Read Level + Probe (LISN) Factor + Cable Loss 2. Over Limit = Level − Limit Line = Margin</neutral></line>	Frequency range Detector Temperature Humidity Adapter Memo	: DES-700 & DC-500 : 150KHz to 30MHz : Peak Value : 24 °C : 49 % : SP35-90300 : CHIME Mode
<ul> <li>Note 1. Level = Read Level + Probe (LISN) Factor + Cable Loss</li> <li>2. Over Limit = Level – Limit Line = Margin</li> </ul>	Test Data : # <u>67.</u> # 67.	$\frac{2}{4}$ < LINE >





Site	Shih-Chi : Conduction No.1(Gene)
Condition	CISPR CLASS-B(QP) LISN.L(16A) LINE
eut	: E930737
power	: AC 230V 50Hz
memo	: Peak Value
	: Final Test

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Freq	Level	Over	Limit Line	Read Level	Probe Factor	Cable Loss	Remark
MHz	dBuV	dB	dBuV	dBuV	dB	dB	
0.152	36.24	-29.63	65.87	35.94	0.20	0.10	
0.302	33.78	-26.41	60.19	33.48	0.20	0.10	
0.513	29.90	-26.10	56.00	29.51	0.20	0.19	
0.796	22.01	-33.99	56.00	21.71	0.20	0.10	
1.535	14.32	-41.68	56.00	13.92	0.20	0.20	
2.396	13.78	-42.22	56.00	13.38	0.20	0.20	
12.124	16.86	-43.14	60.00	16.07	0.39	0.40	
16.140	24.43	-35.57	60.00	23.51	0.52	0.40	
20.162	32.90	-27.10	60.00	31.89	0.61	0.40	
24.271	48.93	-11.07	60.00	47.76	0.77	0.40	
28.302	46.36	-13.64	60.00	45.06	0.80	0.50	
	Freq MHz 0.152 0.302 0.513 0.796 1.535 2.396 12.124 16.140 20.162 24.271 28.302	Freq         Level           MHz         dBuV           0.152         36.24           0.302         33.78           0.513         29.90           0.796         22.01           1.535         14.32           2.396         13.78           12.124         16.86           16.140         24.43           20.162         32.90           24.271         48.93           28.302         46.36	Over           Freq         Level         Limit           MHz         dBuV         dB           0.152         36.24         -29.63           0.302         33.78         -26.41           0.513         29.90         -26.10           0.796         22.01         -33.99           1.535         14.32         -41.68           2.396         13.78         -42.22           12.124         16.86         -43.14           16.140         24.43         -35.57           20.162         32.90         -27.10           24.271         48.93         -11.07           28.302         46.36         -13.64	Over         Limit           Freq         Level         Limit         Line           MHz         dBuV         dB         dBuV           0.152         36.24         -29.63         65.87           0.302         33.78         -26.41         60.19           0.513         29.90         -26.10         56.00           0.796         22.01         -33.99         56.00           1.535         14.32         -41.68         56.00           2.396         13.78         -42.22         56.00           12.124         16.86         -43.14         60.00           16.140         24.43         -35.57         60.00           20.162         32.90         -27.10         60.00           24.271         48.93         -11.07         60.00           28.302         46.36         -13.64         60.00	Over         Limit         Read           Freq         Level         Limit         Line         Level           MHz         dBuV         dB         dBuV         dBuV         dBuV           0.152         36.24         -29.63         65.87         35.94           0.302         33.78         -26.41         60.19         33.48           0.513         29.90         -26.10         56.00         29.51           0.796         22.01         -33.99         56.00         21.71           1.535         14.32         -41.68         56.00         13.92           2.396         13.78         -42.22         56.00         13.38           12.124         16.86         -43.14         60.00         16.07           16.140         24.43         -35.57         60.00         23.51           20.162         32.90         -27.10         60.00         31.89           24.271         48.93         -11.07         60.00         47.76           28.302         46.36         -13.64         60.00         45.06	Over         Limit         Read         Probe           Freq         Level         Limit         Line         Level         Factor           MHz         dBuV         dB         dBuV         dBuV         dB         dBuV         dB           0.152         36.24         -29.63         65.87         35.94         0.20           0.302         33.78         -26.41         60.19         33.48         0.20           0.513         29.90         -26.10         56.00         29.51         0.20           0.796         22.01         -33.99         56.00         21.71         0.20           1.535         14.32         -41.68         56.00         13.92         0.20           2.396         13.78         -42.22         56.00         13.38         0.20           12.124         16.86         -43.14         60.00         16.07         0.39           16.140         24.43         -35.57         60.00         23.51         0.52           20.162         32.90         -27.10         60.00         31.89         0.61           24.271         48.93         -11.07         60.00         47.76         0.77	Over         Limit         Read         Probe         Cable           Freq         Level         Limit         Line         Level         Factor         Loss           MHz         dBuV         dB         dBuV         dBuV         dB         dB         dB           0.152         36.24         -29.63         65.87         35.94         0.20         0.10           0.302         33.78         -26.41         60.19         33.48         0.20         0.10           0.513         29.90         -26.10         56.00         29.51         0.20         0.19           0.796         22.01         -33.99         56.00         21.71         0.20         0.20           1.535         14.32         -41.68         56.00         13.92         0.20         0.20           2.396         13.78         -42.22         56.00         13.38         0.20         0.20           12.124         16.86         -43.14         60.00         16.07         0.39         0.40           16.140         24.43         -35.57         60.00         23.51         0.52         0.40           20.162         32.90         -27.10         60.00 <td< td=""></td<>





Site	:	Shih-Chi : Conduct	tion No.1(Ge	ne)			
Condition	:	CISPR CLASS-B(QP)	LISN.N(16A)	NEUTRA			
eut	:	E930737					
power	z	AC 230V 50Hz					
memo	:	Peak Value					
	:	Final Test					

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	Freq	Level	Over Limit	Limit Line	Read Level	Probe Factor	Cable Loss	Remark
10	MHz	dBuV	dB	dBuV	dBuV	dB	dB	
1	0.310	34.98	-24.99	59.97	34.68	0.20	0.10	
2	0.529	33.54	-22.46	56.00	33.17	0.20	0.17	
3	0.800	24.67	-31.33	56.00	24.37	0.20	0.10	
4	1.426	17.12	-38.88	56.00	16.72	0.20	0.20	
5	8.062	16.04	-43.96	60.00	15.46	0.28	0.30	
6	12.124	19.98	-40.02	60.00	19.19	0.39	0.40	
7	16.140	27.03	-32.97	60.00	26.11	0.52	0.40	
8	20.162	36.08	-23.92	60.00	35.07	0.61	0.40	
9	24.271	47.10	-12.90	60.00	45.93	0.77	0.40	
10	28.302	45.13	-14.87	60.00	43.83	0.80	0.50	





Site	: Shih-Chi : Conduction No.1(Gene)
Condition	: CISPR CLASS-B(QP) LISN.L(16A) LINE
eut	: E930737
power	: AC 120V 60Hz
memo	: Peak Value
	: Final Test

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							F
Freq	Level	Over Limit	Limit Line	Read Level	Probe Factor	Cable Loss	Remark
MHz	dBuV	dB	dBuV	dBuV	dB	dB	
0.152	43.33	-22.54	65.87	43.03	0.20	0.10	
0.251	41.68	-20.05	61.73	41.28	0.20	0.20	
0.461	39.57	-17.10	56.67	39.24	0.20	0.13	
0.783	20.10	-35.90	56.00	19.80	0.20	0.10	
1.535	16.01	-39.99	56.00	15.61	0.20	0.20	
2.721	10.40	-45.60	56.00	10.00	0.20	0.20	
8.062	15.68	-44.32	60.00	15.10	0.28	0.30	
12.124	18.02	-41.98	60.00	17.23	0.39	0.40	
16.140	24.95	-35.05	60.00	24.03	0.52	0.40	
24.271	44.79	-15.21	60.00	43.62	0.77	0.40	
28.302	45.34	-14.66	60.00	44.04	0.80	0.50	
	Freq MHz 0.152 0.251 0.461 0.783 1.535 2.721 8.062 12.124 16.140 24.271 28.302	Freq         Level           MHz         dBuV           0.152         43.33           0.251         41.68           0.461         39.57           0.783         20.10           1.535         16.01           2.721         10.40           8.062         15.68           12.124         18.02           16.140         24.95           24.271         44.79           28.302         45.34	Over           Freq         Level         Limit           MHz         dBuV         dB           0.152         43.33         -22.54           0.251         41.68         -20.05           0.461         39.57         -17.10           0.783         20.10         -35.90           1.535         16.01         -39.99           2.721         10.40         -45.60           8.062         15.68         -44.32           12.124         18.02         -41.98           16.140         24.95         -35.05           24.271         44.79         -15.21           28.302         45.34         -14.66	Over Freq         Level dBuV         Over Limit         Limit Line           MHz         dBuV         dB         dBuV           0.152         43.33         -22.54         65.87           0.251         41.68         -20.05         61.73           0.461         39.57         -17.10         56.67           0.783         20.10         -35.90         56.00           1.535         16.01         -39.99         56.00           2.721         10.40         -45.60         56.00           8.062         15.68         -44.32         60.00           12.124         18.02         -41.98         60.00           16.140         24.95         -35.05         60.00           24.271         44.79         -15.21         60.00           28.302         45.34         -14.66         60.00	Over Freq         Level Level         Limit Limit         Read Level           MHz         dBuV         dB         dBuV         dBuV           0.152         43.33         -22.54         65.87         43.03           0.251         41.68         -20.05         61.73         41.28           0.461         39.57         -17.10         56.67         39.24           0.783         20.10         -35.90         56.00         19.80           1.535         16.01         -39.99         56.00         15.61           2.721         10.40         -45.60         56.00         10.00           8.062         15.68         -44.32         60.00         15.10           12.124         18.02         -41.98         60.00         17.23           16.140         24.95         -35.05         60.00         24.03           24.271         44.79         -15.21         60.00         43.62           28.302         45.34         -14.66         60.00         44.04	Over Freq         Level Level         Limit Limit         Read Line         Probe Level         Factor           MHz         dBuV         dB         dBuV         dBuV         dB         dBuV         dB           0.152         43.33         -22.54         65.87         43.03         0.20           0.251         41.68         -20.05         61.73         41.28         0.20           0.461         39.57         -17.10         56.67         39.24         0.20           0.783         20.10         -35.90         56.00         19.80         0.20           1.535         16.01         -39.99         56.00         15.61         0.20           2.721         10.40         -45.60         56.00         10.00         0.20           8.062         15.68         -44.32         60.00         15.10         0.28           12.124         18.02         -41.98         60.00         17.23         0.39           16.140         24.95         -35.05         60.00         24.03         0.52           24.271         44.79         -15.21         60.00         43.62         0.77           28.302         45.34         -14.66         60.00 </td <td>Over Freq         Level Level         Limit Limit         Read Level         Probe Factor         Cable Loss           MHz         dBuV         dB         dBuV         dBuV         dB         dB           0.152         43.33         -22.54         65.87         43.03         0.20         0.10           0.251         41.68         -20.05         61.73         41.28         0.20         0.20           0.461         39.57         -17.10         56.67         39.24         0.20         0.10           1.535         16.01         -39.99         56.00         19.80         0.20         0.20           2.721         10.40         -45.60         56.00         10.00         0.28         0.30           12.124         18.02         -41.98         60.00         17.23         0.39         0.40           16.140         24.95         -35.05         60.00         24.03         0.52         0.40           24.271         44.79         -15.21         60.00         43.62         0.77         0.40           28.302         45.34         -14.66         60.00         44.04         0.80         0.50</td>	Over Freq         Level Level         Limit Limit         Read Level         Probe Factor         Cable Loss           MHz         dBuV         dB         dBuV         dBuV         dB         dB           0.152         43.33         -22.54         65.87         43.03         0.20         0.10           0.251         41.68         -20.05         61.73         41.28         0.20         0.20           0.461         39.57         -17.10         56.67         39.24         0.20         0.10           1.535         16.01         -39.99         56.00         19.80         0.20         0.20           2.721         10.40         -45.60         56.00         10.00         0.28         0.30           12.124         18.02         -41.98         60.00         17.23         0.39         0.40           16.140         24.95         -35.05         60.00         24.03         0.52         0.40           24.271         44.79         -15.21         60.00         43.62         0.77         0.40           28.302         45.34         -14.66         60.00         44.04         0.80         0.50





	S	
Site	:	Shih-Chi : Conduction No.1(Gene)
Conditio	n:	CISPR CLASS-B(QP) LISN.N(16A) NEUTRAL
eut	:	E930737
power	:	AC 120V 60Hz
memo	:	Peak Value
	:	Final Test

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D	=	$\overline{\mathbf{T}}$	0		
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	Freq	Level	Over Limit	Limit Line	Read Level	Probe Factor	Cable Loss	Remark
S <del>.</del>	MHz	dBuV	dB	dBuV	dBuV	dB	dB	
1	0.253	42.78	-18.86	61.64	42.38	0.20	0.20	
2	0.474	42.67	-13.78	56.45	42.32	0.20	0.15	
3	0.755	31.21	-24.79	56.00	30.91	0.20	0.10	
4	1.381	19.71	-36.29	56.00	19.31	0.20	0.20	
5	8.062	14.00	-46.00	60.00	13.42	0.28	0.30	
6	12.124	17.74	-42.26	60.00	16.95	0.39	0.40	
7	16.140	24.52	-35.48	60.00	23.60	0.52	0.40	
8	20.162	32.06	-27.94	60.00	31.05	0.61	0.40	
9	24.271	46.56	-13.44	60.00	45.39	0.77	0.40	
10	28.302	45.05	-14.95	60.00	43.75	0.80	0.50	

Model No. Frequency ran Detector Femperature Humidity Adapter Memo	nge	: DES-700 & DC-500 : 150KHz to 30MHz : Peak Value : 24 °C : 49 % : AD-0900300DS : CHIME Mode
Test Data :	# <u>684</u> # 682	< LINE >
X Note 1. Lev	el = Read Le	evel + Probe (LISN) Factor + Cable Loss
2. Ove	er Limit = Le	evel – Limit Line = Margin
X Note 1. Leve	el = Read Le	evel + Probe (LISN) Factor + Cable Loss
2. Ove	er Limit = Le	evel – Limit Line = Margin
X Note 1. Leve	el = Read Le	evel + Probe (LISN) Factor + Cable Loss
2. Ove	er Limit = Le	evel – Limit Line = Margin
X Note 1. Leve	el = Read Le	evel + Probe (LISN) Factor + Cable Loss
2. Ove	er Limit = Le	evel – Limit Line = Margin
X Note 1. Leve	el = Read Le	evel + Probe (LISN) Factor + Cable Loss
2. Ove	er Limit = Le	evel – Limit Line = Margin
X Note 1. Leve	el = Read Le	evel + Probe (LISN) Factor + Cable Loss
2. Ove	er Limit = Le	evel – Limit Line = Margin





Site	:	Shih-Chi : Conduction No.1(Gene)
Conditio	on:	CISPR CLASS-B(QP) LISN.L(16A) LINE
eut	:	E930737
power	:	AC 240V 50Hz
memo	:	Peak Value
	:	Final Test

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Dag	0	
E CA M	5	-

	Freq	Level	Over Limit	Limit Line	Read Level	Probe Factor	Cable Loss	Remark
Э	MHz	dBuV	dB	dBuV	dBuV	dB	dB	
1	0.150	33.35	-32.65	66.00	33.05	0.20	0.10	
2	0.317	32.26	-27.54	59.80	31.96	0.20	0.10	
3	0.621	23.77	-32.23	56.00	23.47	0.20	0.10	
4	1.000	22.46	-33.54	56.00	22.06	0.20	0.20	
5	4.027	11.61	-44.39	56.00	11.11	0.20	0.30	
6	12.124	18.30	-41.70	60.00	17.51	0.39	0.40	
7	16.140	25.47	-34.53	60.00	24.55	0.52	0.40	
8	20.162	33.04	-26.96	60.00	32.03	0.61	0.40	
9	24.271	45.61	-14.39	60.00	44.44	0.77	0.40	
10	28.302	45.76	-14.24	60.00	44.46	0.80	0.50	





Site	:	Shih-Chi : Conduction No.1(Gene)
Condition	n :	CISPR CLASS-B(QP) LISN.N(16A) NEUTRAL
eut	2	E930737
power	2	AC 240V 50Hz
memo	:	Peak Value
	:	Final Test

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		~	_			

	Freq	Level	Over Limit	Limit Line	Read Level	Probe Factor	Cable Loss	Remark
1.7	MHz	dBuV	dB	dBuV	dBuV	dB	dB	
1	0.158	34.77	-30.79	65.56	34.47	0.20	0.10	
2	0.334	33.65	-25.70	59.35	33.35	0.20	0.10	
3	0.675	27.14	-28.86	56.00	26.84	0.20	0.10	
4	1.772	15.73	-40.27	56.00	15.33	0.20	0.20	
5	4.006	10.45	-45.55	56.00	9.95	0.20	0.30	
6	8.062	13.29	-46.71	60.00	12.71	0.28	0.30	
7	16.140	22.78	-37.22	60.00	21.86	0.52	0.40	
8	20.162	30.02	-29.98	60.00	29.01	0.61	0.40	
9	24.271	43.17	-16.83	60.00	42.00	0.77	0.40	
10	28.302	44.12	-15.88	60.00	42.82	0.80	0.50	

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## 8. EN 55022 Radiated Disturbance Test

Test Standard	Model No.	Result
EN 55022	DES-700 & DC-500	Passed

#### 8.1 Radiated Disturbance Test Description

Preliminary measurements were made indoors chamber at 3 meter using broadband antennas, broadband amplifier, and spectrum analyzer to determine the frequency producing the maximum EME. Appropriate precaution was taken to ensure that all EME from the EUT were maximized and investigated. The system configuration, clock speed, mode of operation or video resolution, turntable azimuth with respect to the antenna were noted for each frequency found. The spectrum was scanned from 30 to 1000 MHz using logbicon antenna. Above 1GHz, linearly polarized double ridge horn antenna were used.

Final measurements were made outdoors at 10-meter test range using biconical, dipole antenna or horn antenna. The test equipment was placed on a wooden bench situated on a 1.5x1 meter area adjacent to the measurement area. Sufficient time for the EUT, support equipment, and test equipment was allowed in order for them to warm up to their normal operating condition. Each frequency found during pre-scan measurements was re-examined and investigated using Quasi-Peak Adapter. The detector function was set to CISPR quasi-peak mode and the bandwidth of the receiver was set to 120kHz.

The half-wave dipole antenna was tuned to the frequency found during preliminary radiated measurements. The EUT, support equipment and interconnecting cables were re-configured to the set-up producing the maximum emission for the frequency and were placed on top of a 0.8-meter high non-metallic 1 x 1.5 meter table. The EUT, support equipment, and interconnecting cables were re-arranged and manipulated to maximize each EME emission. The turntable containing the system was rotated; the antenna height was varied 1 to 4 meters and stopped at the azimuth or height producing the maximum emission.

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> 8.2 Radiated Disturbance Test Setup 10m 4m (EUT) 1 m0.8m GROUND PLANE TURN TABLE TO RECEIVER EUT = Equipment Under Test

Limits for radiated dis a measuring	turbance of Class A ITE at distance of 10 m
Frequency MHz	Field Strength dB( µ V/m)
30 to 230	40
230 to 1 000	47

## Limits for radiated disturbance of Class B ITE at a measuring distance of 10 m

Frequency MHz	Field Strength dB( µ V/m)
30 to 230	30
230 to 1 000	37

#### NOTES

1 The lower limit shall apply at the transition frequency.

2 Additional provisions may be required for cases where interference occurs.

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Mod Freq Tem Mem	el No. uency rang perature 10 Antenna	: DES ge : 30N : 24 : CH	S-700 & D 1Hz to 1G I <sup>o</sup> C IME Mod ization : _	C-500 Hz D H e <u>VERTI</u>	etector umidity CAL ;	: Qua : 49 Test	asi-Peak V 9 % distance :	alue : <u>10m</u>	<u>;</u>
		Over	Limit	Read	Antenna	Cable	Preamp		
Freq.	Level	Limit	Line	Level	Factor	Loss	Factor	Azimuth	Antenna
(MHz)	(dBuV/m)	(dB)	(dBuV/m)	(dBuV)	(dB)	(dB)	(dB)	(°angle)	High(m)
34.622	27.64	-2.36	30.00	35.71	10.92	0.59	19.58	119.0	1.0
40.306	24.17	-5.83	30.00	31.80	11.36	0.60	19.59	184.0	1.0
44.333	25.89	-4.11	30.00	33.73	11.07	0.60	19.51	203.0	1.0
52.239	23.28	-6.72	30.00	31.38	10.57	0.80	19.47	149.0	1.3
134.889	17.05	-12.95	30.00	21.28	13.97	1.10	19.30	165.0	1.0
160.783	20.40	-9.60	30.00	21.90	16.69	1.30	19.49	250.0	1.5

Note :

Level = Read Level + Antenna Factor + Cable Loss – Preamp Factor Over Limit = Level – Limit Line 1.

2.

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## 9. EN 61000-3-2 Harmonic Current Test

Test standard	Model No.	Result
EN 61000-3-2	DES-700 & DC-500	Passed

#### 9.1 Harmonic Current Test Description

The equipment under test is supplied in series with shunt(s) Rm or current transformer(s) from a source having the same nominal voltage and frequency as the rated supply voltage and frequency of the equipment under test. Whether the equipment operates with automatic , mixed or manual control , the measurements shall be made under normal load , or conditions for adequate heat discharge , and under normal operating conditions.

User's operation controls or automatic programmers shall be set to produce the maximum harmonic component, for each successive harmonic component in turn.

For the purpose of harmonic current limitation , equipment is classified as follows : Class A :

- Balanced three-phase equipment;
- Household appliances excluding equipment identified as Class D;
- Tools excluding portable tools;
- Dimmers for incandescent lamps;
- Audio equipment.

Equipment not specified in one of the three other classes shall be considered as Class A equipment.

NOTE 1 Equipment that can be shown to have a significant effect on the supply system may be reclassified in a future edition of the standard. Factors to be taken into account include :

- number in use;
- duration of use;
- simultaneity of use;
- power consumption;
- harmonic spectrum, including phase.

Class B: Portable tools.

Portable tools;

- Arc welding equipment which is not professional equipment.

Class C :

- Lighting equipment.
- Class D :

Equipment having a specified power according to 6.2.2 less than or equal to 600W, of the following types:

- Personal computers and personal computer monitors;

- Television receivers.

NOTE 2 Class D limits are reserved for equipment that, by virtue of the factors listed in note 1, can be shown to have a pronounced effect on the public electricity supply system.

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9.4 Harmonic Current Test Limits

Harmonic order n	Maximum permissible harmonic current A					
Odd harmonics						
3	2.30					
5	1.14					
7	0.77					
9	0.40					
11	0.33					
13	0.21 15					
13<-11<-39	$0.15{n}$					
Even h	armonics					
2	1.08					
4	0.43					
6	0.30 8					
8<=n<=40	$0.23\frac{6}{n}$					

#### Note :

- 1. For Class A equipment, the harmonics of the input current shall not exceed the absolute values given in table 1.
- 2. For Class B equipment, the harmonics of the input current shall not exceed the values given in table 1 multiplied by a factor of 1,5.

Harmonic order	Maximum permissible harmonic current expressed as a percentage of the input current at the fundamental frequency.
	at the fundamental frequency
n	0/0
2	2
3	30·λ*
5	10
7	7
9	5
11<=n<=39	3
(odd harmonics only)	
* $\lambda$ is the circuit power factor	

#### Table 2 Limits for Class C equipment

#### Note :

The harmonic current limits of lighting equipment shall not exceed the relative limits given in table 2.

Harmonic	Maximum permissible harmonic current per watt	Maximum permissible harmonic current
n	mA/W	А
3	3.4	2.30
5	1.9	1.14
7	1.0	0.77
9	0.5	0.40
11	0.35	0.33
13<=n<=39	3.85	See table 1
(odd harmonics only)	n	

#### Table 3 Limits for Class D equipment

Note :

The harmonics of the input current shall not exceed the values that can be derived from table 3.



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		Madal	• DE	S 700 & DC 5	200
		Line Voltage	: DE	$S - 100 \approx DC - 3$	00
		RMS Current	· 0.0	ν ντιτις 15 Δ	
		Real Power	· 2.5	19 A 19 W	
		Fundamental Amp	· 37	2 mArms	
		Line Frequency	: 50	Hz	
		Device Class	: A		
Harm.	Indicated	Max. Permits	Harm.	Indicated	Max. Permits
Order	Values	Harm. Current	Order	Values	Harm. Current
-		Ampere			Ampere
			2	0.000	1.08
3	0.004	2.30	4	0.000	0.43
5	0.003	1.14	6	0.000	0.30
7	0.001	0.77	8	0.000	0.23
9	0.000	0.40	10	0.000	0.18
11	0.000	0.33	12	0.000	0.15
13	0.000	0.21	14	0.000	0.13
15	0.000	0.15	16	0.000	0.12
17	0.000	0.13	18	0.000	0.10
19	0.000	0.12	20	0.000	0.09
21	0.000	0.11	22	0.000	0.08
23	0.000	0.10	24	0.000	0.08
25	0.000	0.09	26	0.000	0.07
27	0.000	0.08	28	0.000	0.07
29	0.000	0.08	30	0.000	0.06
31	0.000	0.07	32	0.000	0.06
33	0.000	0.07	34	0.000	0.05
35	0.000	0.06	36	0.000	0.05
37	0.000	0.06	38	0.000	0.05

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## **10. EN 61000-3-3 Voltage Fluctuations Test**

Test standard	Model No.	Result
EN 61000-3-3 DES-700 & DC-500		Passed

#### **10.1 Voltage Fluctuations Test Description**

EN 61000-3-3 standards define the measurement requirements, ac power source requirements, line impedance requirements, and voltage fluctuation and flicker limits for assessing electronic and electrical equipment's propensity to cause voltage disturbances on the ac mains. Compliance with these standards ensures that voltage fluctuations do not interfere with other equipment connected to the ac mains or cause incandescent lights to visibly flicker in a way that causes an annoyance or health risk to a human observer.

When automatic controls cycle on and off, they cause frequent changes of toehold to the supply. When the fluctuating load is in a branch circuit with other loads, these changes cause rms voltage fluctuations that affect all of the loads in the branch. In particular, variations in voltage amplitude cause changes in the light output of any filament lamps in the branch circuit. Because the output of a filament lamp is proportional to the square of the applied voltage, changes in light intensities can be significant even for small changes in voltage.
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## **10.2 Voltage Fluctuations Test Limits**

The limits shall be applicable to voltage fluctuations and flicker at the supply terminals of the equipment under test.

The following limits apply:

- the value of  $P_{\rm st}$  shall not be greater than 1.0;
- the value of  $P_{\rm it}$  shall not be greater than 0.65;
- the value of d(t) during a voltage change shall not exceed 3.3% for more than 500 ms;
- the relative steady-state voltage change,  $d_c$ , shall not exceed 3.3%;
- the maximum relative voltage change  $d_{\text{max}}$ , shall not exceed
  - a) 4% without additional conditions;
  - b) 6% for equipment which is:
    - switched manually, or
    - switched automatically more frequently than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds), or manual restart, after a power supply interruption.

NOTE The cycling frequency will be frequency will be further limited by the  $P_{st}$  and  $P_{it}$  limit. For example: a  $d_{max}$  of 6% producing a rectangular voltage change characteristic twice per hour will give a  $P_{it}$  of about 0.65.

- c) 7% for equipment which is
  - attended whilst in use (for example: hair dryers, vacuum cleaners, kitchen equipment such as mixers, garden equipment such as lawn mowers, portable tools such as electric drills), or
  - switched on automatically, or is intended to be switched on manually, no mote than twice per day, and also has either a delayed restart (the delay being not less than a few tens of seconds) or manual restart, after a power supply interruption.





Мо	del No :	DES-700 & DC-500	
RMS Voltage	: 230 V	RMS Curren	t : 0.015 A
Real Power	: 2.491 W	Peak Curren	t : 0.028 A
Apparent Pov	ver : 3.514 VA	Frequency	: 50.0 Hz
	Indicated Values	Limit	Pass(P) or
			Fail (F)
Pst	0.072	< 1.0	Р
Plt	0.072	< 0.65	Р
D	0.00%	< 3.3%	Р
Dc	0.00%	< 4%	Р
Dc Dmax			

Plt: Long-term flicker indicator

Dc: Relative steady state voltage change

Dmax: Maximum relative voltage change

D(t): Voltage change

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# 11. EN 61000-4-2 Electrostatic Discharge Test

Test standard	Model No.	Result
EN 61000-4-2	DES-700 & DC-500	Passed

#### **Criteria for Compliance:**

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the discharges is permissible, providing that there is no residual change in the EUT or any change in outputs.

## **11.1 Electrostatic Discharge Test Description**

This standard relates to equipment, systems, sub-systems and peripherals which may be involved in static electricity discharges owing to environmental and installation conditions. such as low relative humidity, use of low-conductivity (artificial-fiber) carpets, vinyl garments, etc., which may exist in allocations classified in standards relevant to electrical and electronic equipment.

The test set-up shall consist of a wooden able, 0.8 m high standing on the ground reference plane. A horizontal coupling plane(HCP),  $1.6 \text{ m} \times 0.8 \text{ m}$ , shall be placed on the table. The EUT and cables shall be isolated from the coupling plane by an insulating support 0.5 mm thick .

A ground reference plane shall be provided on floor of the laboratory. It shall be metallic sheet of 0.25 mm minimum thickness. The minimum size of the reference plane is 1 m, the exact size depending on the dimensions of the EUT.

It shall project beyond the EUT or coupling plane by at least 0.5 m on all sides. and shall be connected to the protective grounding system.

In order to minimize the impact of environmental parameters on test results, the tests shall be carried out in climatic and electromagnetic reference conditions.

Climatic conditions

- ambient temperature:	15 °C to 35°C;
- relative humidity:	30 % to 60%
- atmospheric pressure:	86 KPa (860 mbar) to 106 KPa (1060 mbar).
NOTE – Any other values are speci	fied in the product specification.

Electromagnetic conditions

The electromagnetic environment of the laboratory shall not influence the test results.

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REPORT NO. : E930737 **11.2 Electrostatic Discharge Test Setup** STATUTE. Typical printing for stene (mon Wender. 7 + 0.8 m in. - Example of test set-up for table-top equipment, laboratory tests

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# 11.3 Electrostatic Discharge Test Limits

Test voltages <sup>1</sup> ):		
Air discharges	(kV)	2;4 & 8
Contact discharges	(kV)	2; 4 & 6
Polarity		+&-
Number of discharges per point for each voltage at	nd polarity	10
Interval between discharges	(s)	=1
<sup>1)</sup> The test voltages specified are the open-circuit ve	oltages.	•
The test voltages for the lower severity levels are	included	
because all the lower severity levels must also be	e satisfied.	

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Moc	lel	Ν	Jo. : DES-700 & DC-500								_					
Те	st I	tem :	Direo	et D	ischa	rge		Ins	trume	ent :	Nois	eKen	ESS-	100L		
Te	mper	ature	:	22	°(	<u> </u>		Rela	ative	Hur	nidity	r :	58	%R	H	
Sto	orage	Caj	pacito	or :	150	pf	Di	schar	ge l	Resist	or :	33(	) Ohn	1		
D1	schar	ge I	<u>Cont</u>	: act	< Discl	l / Se	c				Ai	r Di	ischai	rae		
	2 H	ΧV	41	XV	6 H	KV	81	ΚV	2 H	ΚV	4 1	KV KV	6 H	KV	8 F	ΚV
	+	-	+	-	+	-	+	-	+	-	+	-	+	-	+	-
1	Р	Р	Р	Р	Р	Р	/	/	Р	Р	Р	Р	/	/	Р	Р
2	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
3	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
4	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
5	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
6	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
7	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
8	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
9	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
0	/	/	/	/	/	/	/	/	Р	Р	Р	Р	/	/	Р	Р
	w 1	D ″		mean	ns tk	ne F	TT	funct	ion	is c	orrec	t du	ring	the	test	

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ESS-10		
	0L	
8 %R	H	
hm		
harge	8 K I	V
	+	<u>v</u>
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	harge       6 KV       +     -       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /	harge       6 KV     8 K°       +     -       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /       /     /

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# 12. EN 61000-4-3 Radio-Frequency Electromagnetic Field Test

Test standard	Model No.	Result
EN 61000-4-3	DES-700 & DC-500	Passed

 Field Strength :
 10
 V/M ,

 Modulation :
 AM
 80 % ,
 1KHz .
 ON (<u>YES</u>) .
 OFF (\_\_\_\_)

 Start :
 80
 MHz ,
 Stop :
 1000
 MHz .
 AC Power :
 230
 Vac

 Pulse modulation:
 1
 Hz
 ON (<u>YES</u>) .
 OFF (\_\_\_\_)

#### Criteria for Compliance:

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs.

### **12.1 Radio-Frequency Electromagnetic Field Test Description**

Most electronic equipment is, in some manner, affected by electromagnetic radiation. This radiation is frequently generated by such sources as the small hand-held radio transceivers that are used by operating, maintenance and security personnel, fixed-station radio and television transmitters, vehicle radio transmitters, and various industrial electromagnetic sources.

In addition to electromagnetic energy deliberately generated, there is also spurious radiation caused by devices such as welders, thyristors, fluorescent lights, switches operating inductive loads, etc. For the most part, this interference manifests itself as conducted electrical interference and, as such, is dealt with in other parts of this standard. Methods employed to prevent effects from electromagnetic fields will normally also reduce the effects from these sources.

The electromagnetic environment is determined by the strength of the electromagnetic field (field strength in volts per meter). The field strength is not easily measured without sophisticated instrumentation nor is it easily calculated by classical equations and formulae because of the effect of surrounding structures or the proximity of other equipment that will distort and/or reflect the electromagnetic waves.

All testing of equipment shall be performed in a configuration as close as possible to the installed case. Wiring shall be consistent with the manufacturer's recommended procedures, and the equipment shall be in its housing with all covers and access panels in place, unless otherwise stated.

If the equipment is designed to be mounted in a panel, rack or cabinet, it shall be tested in this configuration.



12.3 Radio-Frequency Electromagnetic Field Test Limits					
Frequency range	(MHz)	80 to 1000			
Frequency range Field strength <sup>1)</sup>	(MHz) (V/m)	80 to 1000 10			
Frequency range Field strength <sup>1)</sup> Modulation:	(MHz) (V/m)	80 to 1000 10			
Frequency range Field strength <sup>1)</sup> Modulation: Amplitude modulation	(MHz) (V/m)	80 to 1000 10 80%, 1 kHz, sinusoidal			

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<sup>1)</sup> The field strength quoted is the RMS value for the continuous wave, before modulation.

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# 13. EN 61000-4-4 Fast Transient Burst Test

Test standard	Model No.	Result
EN 61000-4-4	DES-700 & DC-500	Passed

#### **Criteria for Compliance:**

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the bursts is permissible, providing that there is no residual change in the EUT or any change in outputs.

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## **13.1 Fast Transient Bursts Test Description**

The repetitive fast transient test is a test with bursts consisting of a number of fast transients, coupled into power supply, control and signal ports of electrical and electronic equipment. Significant for the test are the short rise time, the repetition rate and the low energy of the transients.

The test shall be carried out on the basis of a test plan including verification of the performances of the EUT as defined in the technical specification.

Climatic conditions

The tests shall be carried out in standard climatic conditions in accordance with IEC 68-1:

- ambient temperature:	15°C	to 35°C
------------------------	------	---------

- relative humidity: 25% to 75%

- atmospheric pressure: 86kPa (860 mbar) to 106Kpa (1060 mbar)

NOTE – Any other values are specified in the product specification.

#### Electromagnetic conditions

The electromagnetic conditions of the laboratory shall be such to guarantee the correct operation of the EUT in order not to influence the test results.

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## **13.3 Fast Transient Burst Test Limits** Test voltages:<sup>1)</sup> 0.5; 1 & 2 a. c. mains supply lines (kV) other supply/signal lines (kV) 0.25; 0.5 & 1 +&-Polarity Number of applications for each voltage and polarity 1 1<sup>+0.2</sup> - 0 Duration per application (min) <sup>1)</sup> The test voltages specified are the open-circuit voltages. The test voltages for the lower

severity levels are included because all the lower severity levels must also be satisfied.





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MODEL NO.	:		DES-70	00 & DC-5	500		
REGULATION	: Acc	ording	to EN 6	1000-4-4	( 1995+,	A2: 2001	) Spe
TEST RESULT	1				1		
Temperature : 22	degree.			Last :	<u> </u>	<u>mın .</u>	
Relative Humidity :	<u>58 % RF</u>	<u>I.</u>		Rest :	60	second.	-
Pulse : $5/50$ ns.				AC Pov	ver : <u>N</u>	V/A Vao	2.
Burst : 15 ms / 300	ms .			DC Pov	ver :	12 Vdc	<u>).</u>
Voltage \ Polar	ity	0.5	KV	11	<b>KV</b>	2ŀ	<u>(V</u>
\Test Point \ Mode	\ Result	+	-	+	-	+	_
	L	Р	Р	Р	Р	Р	Р
Power Line	N	P	Р	Р	Р	Р	P
	G	/	/	/	/	/	/
Signal Lines <sup>4)</sup>				U.	<u>5 K v</u>	<u>11</u>	
Clamp Test		P	P	P	- P	P	P
Note : 1. "P" me. 2. "F"	an the E	EUT fun	ction is	correct	during	the tes	t .

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# 14. EN 61000-4-5 Surge Immunity Test

Test standard	Model No.	Result
EN 61000-4-5	DES-700 & DC-500	Passed

#### Criteria for Compliance:

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the application of the surge is permissible, providing that there is no residual change in the EUT or any change in outputs.

## 14.1 Surge Immunity Test Description

The task of the described laboratory test is to find the reaction of the EUT under specified operational conditions caused by surge voltages from switching and lightning effects at certain threat levels.

The following equipment is part of the test set-up :

- equipment under test (EUT);
- auxiliary equipment (AE);
- cables (of specified type and length);
- coupling device (capacitive or arrestors);
- test generator (combination wave generator,  $1.2/50 \ \mu s$  generator);
- decoupling network/protection devices;
- additional resistors, 10 ohm and 40 ohm

The surge is to be applied to the EUT power supply terminals via the capacitive coupling network. Decoupling networks are required in order to avoid possible adverse effects on equipment not under test that may be powered by the same lines and to provide sufficient decoupling impedance to the surge wave so that the specified wave may be developed on the lines under test .

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## 14.3 Surge Immunity Test Limits

Test voltages <sup>1)</sup> :		
a. c. mains supply lines:		
- line-to-line	(kV)	0.5 & 1
- line-to-ground <sup>2)</sup>	(kV)	0.5; 1& 2
other supply/signal lines:		
- line-to-ground <sup>3)</sup>	(kV)	0.5 & 1
Polarity		+ & -
Minimum number of surges at each pol voltage, coupling mode and line:	arity,	
- a. c. mains supply lines		20 <sup>4)</sup>
- other supply/signal lines		5

<sup>1)</sup> The test voltages specified are the open-circuit voltages. The test voltages for the lower severity levels are included, because all the lower severity levels must also be satisfied.

<sup>2)</sup> via a 10 O series resistor.

<sup>3)</sup> via a 10 O series resistor.

<sup>4)</sup> 5 at each zero-crossing point and at the maximum and minimum points on he mains voltage wave.

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14.5 Surge Immunity Test Data MODEL NO : DES-700 & DC-500 TEST SETUP: According to EN 61000-4-5 (1995+A1: 2001) Temperature : 22 °C Relative Humidity 58 %RH Waveform :  $1,2 \times 50 \mu s$ Test rate : <u>15</u> sec Times \_\_\_\_ 20 times / each condition AC power 230 VAC \Phase 90 0 45 135 180 215 270 315 \Voltage\Mode\Polarity\Result a.c. mains Line +Р Р Р Р Р Р Р Р supply Neutral Р Р Р Р Р Р Р \_ Р 0.5KV a.c. mains Р Line +Р Р Р Р Р Р Р supply Neutral \_ Р Р Р Р Р Р Р Р 1KV a.c. mains Line +/ / / / / / / / Ground supply / / / / / / / / \_ 0.5KV Neutral +/ / / / / / / / 1KV Ground 2KV / / / / / / / / Line +/ / / / / / / / Ground Signal line / / / / / / / / \_ 0.5KV / / Neutral +/ / / / / / 1KV Ground / / / / / / / / Note: 1. " P " means the EUT function is correct during the test 2. "/" no test

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# 15. EN 61000-4-6 Immunity To Conducted Disturbances, Induced By Radio-Frequency Fields

Test standard	Model No.	Result
EN 61000-4-6	DES-700 & DC-500	Passed

#### **Criteria for Compliance:**

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs.

For components of CCTV systems, where the status is monitored by observing The TV picture, then deterioration of the picture is allowed at Uo = 140 dBuV.

## 15.1 Immunity To Conducted Disturbances, Induced By Radio-Frequency Fields Test Description

The EUT shall be placed on an insulating support, 0.1 m above the ground reference plane. For table-top equipment, the ground reference plane may be placed on a table (see figure).

On all cables to be tested, coupling and decoupling devices shall be inserted. The coupling and decoupling devices shall be placed on the ground reference plane, making direct contact with it at about 0.1 m to 0.3 m from the EUT. The cables between the coupling and decoupling devices and the EUT shall be as short as possible and shall not be bundled nor wrapped. height above the ground reference plane shall be between 30 mm and 50 mm.

If the EUT is provided with other earth terminals, they shall, when allowed, be connected to the ground reference plane through the coupling and decoupling network CDN-M1, (i.e. the AE port of the CDN-M1 is then connected to the ground reference).

If the EUT is provided with a keyboard or hand-held accessory, then the artificial hand shall be placed on this keyboard or wrapped around the accessory and connected to the ground reference plane.

Auxiliary equipment (AE) required for the defined operation of the EUT according to the specifications of the product committee, e.g. communication equipment, modem, printer, sensor, etc., as well as auxiliary equipment necessary for ensuring any data transfer and assessment of the functions, shall be connected to the EUT through coupling and decoupling devices. However, as far as possible the number of cables to be tested should be limited by restricting attention to the representative functions.



## 15.3 Immunity To Conducted Disturbances, Induced By Radio-Frequency Fields Test Limits

No tests are required for induced disturbances caused by electromagnetic fields coming from intentional RF transmitters in the frequency range 9 kHz to 150 kHz,

The open-circuit test levels (e.m.f.) of the unmodulated disturbing signal, expressed in r.m.s., are given in table 5. The test levels are set at the EUT port of the coupling and decoupling devices. For testing of equipment, this signal is 80% amplitude modulated with a 1 kHz sine wave to simulate actual threats. The pulse modulation is 1 Hz.

Frequency range	(MHz)	0.15 to 100
Voltage level (emf) <sup>1)</sup> Uo	(dBµV)	140
	(V)	(10)
Modulation:		
Amplitude modulation		80%, 1 kHz, sinusoidal
Pulse modulation		1 Hz (0.5 s ON: 0.5 s OFF)

<sup>1)</sup> The voltage level quoted is the open-circuit RMS value for the continuous wave, before modulation.



MODEL NO.	: DES-700 & DC	-500
REGULATION	: EN 61000-4-6 (1996	G+A1: 2001)
TEST RESULT		
Start: <u>0.15MHz</u> , Pulse modulation: <u>1Hz</u>	Stop : <u>100 MHz</u> ON ( <u>Y</u> Frequency(MHz)	, <u>ES</u> ), OFF () Uo=140dBuV
T D	Range	10V
Test Ports Input / Output	0.15 100	PASS
Test Ports Input / Output a. c. power	0.15 100	PASS

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# 16. EN 61000-4-11 Main Supply Voltage Dips and Short Interruptions Immunity Tests

## 16.1 Main Supply Voltage Dips and short Interruptions Immunity Tests Description

Electrical and electronic equipment may be affected by voltage dips, short interruptions or voltage variations of power supply.

Voltage dips and short interruptions are caused by faults in the network, in installations or by a sudden large change of load. In certain cases, two or more consecutive dips or interruptions may occur. Voltage variations are caused by the continuously varying loads connected to the network. Before starting the test of a given equipment, a test plan shall be prepared.

It is recommended that the test plan shall comprise the following items :

- the type designation of the EUT;
- information on possible connections (plugs, terminals, etc.) and cables, and peripherals;
- input power port of equipment to be tested;
- representative operational modes of the EUT for the test;
- performance criteria used and defined in the technical specifications;
- operational mode(s) of equipment;
- description of the test set-up.

If the actual operating signal sources are not available to the EUT, they may be simulated.

For each test any degradation of performance shall be recorded.

The monitoring equipment should be capable of displaying the status of the operational mode of the EUT during and after the tests. After each group of tests a full functional check shall be performed.


## 16.3 Main Supply Voltage Dips and short Interruptions Immunity Tests Limits

Voltage reduction	(%)	60	100
Duration of reduction		0.5; 1; 5 & 10	0.5; 1 & 5
(No.) of periods)		& 10	
(i. e. cycles of the voltage wave)			
Number of reductions at each duration		3	3
Interval between reductions	(s)	= 10	= 10



## 16.5 Main Supply Voltage Dips and short Interruptions Immunity Tests Data

MODEL NO. : <u>DES-700 & DC-500</u>

REGULAR : EN 61000-4-11 (1996+A1: 2001)

TEST RESULT : Test Voltage 230Vac

Dips and Short Interruptions	Test Level %U <sub>T</sub>	Duration Periods	Result
	30%	0.5;1;5&10	PASS
	60%	0.5;1;5&10	PASS
	100%	0.5;1&5	PASS

Note : 0.5 Period = 10ms 1 Period = 20ms 5 Period = 100ms 10 Period = 200ms

#### **Criteria for Compliance :**

There shall be no damage, malfunction or change of status due to the conditioning. Flickering of an indicator during the conditioning is permissible, providing that there is no residual change in the EUT or any change in outputs, which could be interpreted by associated equipment as a change. 12-3Fl, No. 27-1, Lane 169, Kang-Ning St., Hsi-Chih, Taipei Hsien, Taiwan, R. O. C. TEL: 886-2-26922097 FAX: 886-2-26956236

# 17. EN 50130-4 Clause 7 Mains Supply Voltage Variations Test

Test standard	Model No.	Result
EN 50130-4 Clause 7	DES-700 & DC-500	Passed

#### **Criteria for Compliance:**

There shall be no damage, malfunction or change of status due to the different supply voltage conditions. The EUT shall meet the acceptance criteria for the functional test, during the conditioning.

## 17.1 EN 50130-4 Clause 7 Mains Supply Voltage Variations Tests Description

To demonstrate the ability of the equipment to function correctly over the anticipated range of mains supply voltage conditions.

Subject the specimen to each of the power supply conditions, indicated in table 1, until temperature stability is reached:

Table 1				
Supply voltage max	(Umax)	Unom + 10%		
Supply voltage min	(Umin)	Unom – 15%		
Unom = Nominal mains v	voltage. Whe	ere provision is made to		
Adapt the equipment to su	uit a number	of nominal supply voltages		
(e.g. by transformer tap cl	nanging), the	e above conditioning		
severity shall be applied for each nominal voltage, with the				
equipment suitably adapted. For equipment which is claimed to				
be suitable for a range of a	nominal mai	ns voltages(e.g.220/240 V)		
without adaptation, Umax	x = (Maximu	m Unom $) + 10\%$ ,and Umin =		
(Minimum Unom) – 15%	. In any case	the range of Unom must		
include the European non	ninal mains v	voltage of 230 V.		



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Test Mode	Instrument	Model No.	Serial No.	Next Cal. Date	Cal. Interval
	R & S Receiver	ESHS10	830223/008	May 22, 2005	1Year
Conduction	Rolf Heine LISN	NNB-4/63TL	98008	May 01, 2005	1Year
(No.1)	R & S LISN	ESH3-Z5	844982/039	Aug. 07, 2005	1Year
	Spectrum Analyzer	R3261A	91720076	Jun. 09, 2005	1Year
	RF Cable	Rg400	N/A	May 12, 2005	1Year
	Schaffner ISN	T411	N/A	Jun. 30, 2005	1Year
	R & S Receiver	ESBI	845658/003	Sep. 07, 2005	1Year
	Schaffner Pre-Amp.	CPA-9232	1012	Aug. 21, 2005	1Year
	SCHWARZBECK Antenna	9161	9161-4051	May 06, 2005	1Year
Radiation	COM-Power Horn Ant.	AH-118 (1GHz~18GHz)	10095	May 21, 2005	1Year
(OP No.3)	RF Cable	No.2	N/A	Feb. 19, 2005	1Year
	SCHWARZBECK Precision Dipole Ant.	VHAP (30MHz~1GHz)	970+971 953+954	Jun. 27, 2006	3Year
	R & S Signal Generator	SMY01	829846/038	Feb. 16, 2005	2Year

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	m (					
	Test item	Instrument	Model No.	Serial No.	Next Cal. Date	Cal. Interval
		(EMC-PARTNER) Transient Tester	TRA-2000/N6	456	Aug. 13, 2005	1Year
-4-2 -4-4 -4-5 -4-11	-4-2 -4-4	(EMC-PARTNER) ESD Test System	TRA1Z03B	399	Aug. 13, 2005	1Year
	-4-5 -4-11	(EMC-PARTNER) EFT/B Clamp	TAR1Z03B	CNEFT 1000-268	Aug. 13, 2005	1Year
EMS	EMS	(EMC-PARTNER) Magnetic Field Loop antenna	MF-1000	MF 1000-169	Aug. 13, 2005	1Year
(NO.2)	-4-6	CONDUCTED IMMUNITY	CIT-10 /102C3117	102C3117	Jul. 24, 2006	2Years
	-3-2 -3-3	(EMC-PARTNER) Harmonic/ Flicker	HAR-1000	66	Jul. 22, 2006	2Years
	4-3	Comtest G-Strip	G-320	CC112-0008	Oct. 01, 2006	2Year

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# VERIFICATION

## of conformity with European EMC Directive

#### No. E930737

Document holder.	Yuan Hsun Electric Co., Ltd.
Type of equipment:	Door Entry Alarm & Counting System
Type designation:	DES-700 & DC-500

A sample of the equipment has been tested for CE-marking according to the EMC Directive, 89/336/EEC. & 92/31/EEC & 93/68/EEC Standard(s) used for showing compliance with the essential requirements of the directive:

Standard(s):

EN 55022 : 1998+A1: 2000 EN 61000-3-2:2000 EN 61000-3-3:1995+A1: 2001

EN 50130-4 :1995+A1:1998

EN 61000-4-2: 1995 + A2: 2001 EN 61000-4-3: 1996 + A2: 2001 EN 61000-4-4: 1995 + A2: 2001 EN 61000-4-5: 1995 + A1: 2001 EN 61000-4-6: 1996 + A1: 2001 EN 61000-4-11: 1994 + A1: 2001 Main Supply Voltage Variations

The referred test report(s) show that the product fulfills the requirements in the EMC Directive for CE marking. On this basis, together with the manufacturer's own documented production control, the manufacturer (or his European authorized representative) can in his EC Declaration of Conformity verify compliance with the EMC Directive.

**Signed for and on behalf of** PEP Testing Laboratory

Class B

Performance Criterion



M. J. Toui

M. Y. Tsui / President

Date: NOV. 23, 2004

# **Declaration of Conformity**

The following

Applicant	:	Yuan Hsun Electric Co., Ltd.
Equipment	:	Door Entry Alarm & Counting System
Model No.	:	DES-700 & DC-500
Report No.	:	E930737

is herewith confirmed to comply with the requirements set out in the Council Directive on the Approximation of the Laws of the Member States relating to Electromagnetic Compatibility(89/336/EEC) and the amendments in the Council Directive 92/31/EEC, 93/68/EEC.

For the evaluation of above mentioned Directives, the following standards were applied:

- 1) EN 55022: 1998+A1 : 2000 Class B
- 2) EN 61000-3-2 : 2000
- 3) EN 61000-3-3 : 1995+A1: 2001
- 4) EN 50130-4:1995 +A1:1998
- EN 61000-4-2 : 1995+A2: 2001 EN 61000-4-3 : 1996+A2: 2001 EN 61000-4-4 : 1995+A2: 2001 EN 61000-4-5 : 1995+A1: 2001 EN 61000-4-6 : 1996+A1: 2001 EN 61000-4-11 : 1994+A1: 2001 Main Supply Voltage Variations

The following manufacturer is responsible for this declaration:

Yuan Hsun Electric Co., Ltd.

No. 57, Chung He Rd., Zuo-Ying Dist., Kaohsiung City 813, Taiwan, R. O. C.

<u>Taiwan / NOV. 23, 2004</u>

Place and Date

Signature of responsible Person